

Notice of References Cited	Application/Control No. 10/840,110		Applicant(s)/Patent Under Reexamination WEEL, MARTIN	
	Examiner OANH DUONG		Art Unit 2155	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0256669	11-2006	Sakuma et al.	369/030.01
*	B	US-7,000,188	02-2006	Eustace, Robert Alan	715/716
*	C	US-6,041,311	03-2000	Chislenko et al.	705/27
*	D	US-6,088,722	07-2000	Herz et al.	709/217
*	E	US-2005/0165888	07-2005	Elliott, Geoffrey	709/203
*	F	US-2004/0181604	09-2004	Immonen, Pekka S.	709/232
*	G	US-2001/0053994	12-2001	Atcheson et al.	705/10
*	H	US-2004/0078382	04-2004	Mercer et al.	707/102
*	I	US-2004/0162830	08-2004	Shirwadkar et al.	707/010
*	J	US-2003/0014759	01-2003	Van Stam, Wijnand	725/97
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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